

Rui Zhang

List of Publications by Year in descending order

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15
papers

557
citations

933447

10
h-index

1372567

10
g-index

15
all docs

15
docs citations

15
times ranked

917
citing authors

#	ARTICLE	IF	CITATIONS
1	Elastic properties of suspended multilayer WSe ₂ . Applied Physics Letters, 2016, 108, .	3.3	121
2	Controlled Layer Thinning and p-Type Doping of WSe ₂ by Vapor XeF ₂ . Advanced Functional Materials, 2017, 27, 1702455.	14.9	103
3	Formation mechanism and orientation of Cu ₃ Sn grains in Cu-Sn intermetallic compound joints. Materials Letters, 2013, 110, 137-140.	2.6	74
4	Mechanical Properties of Atomically Thin Tungsten Dichalcogenides: WS ₂ , WSe ₂ , and WTe ₂ . ACS Nano, 2021, 15, 2600-2610.	14.6	65
5	Relationship between morphologies and orientations of Cu ₆ Sn ₅ grains in Sn _{3.0} Ag _{0.5} Cu solder joints on different Cu pads. Materials Characterization, 2014, 88, 58-68.	4.4	63
6	Phase transformation and grain orientation of Cu-Sn intermetallic compounds during low temperature bonding process. Journal of Materials Science: Materials in Electronics, 2013, 24, 3905-3913.	2.2	52
7	Electromigration-induced intermetallic growth and voids formation in symmetrical Cu/Sn/Cu and Cu/Intermetallic compounds (IMCs)/Cu joints. Journal of Materials Science: Materials in Electronics, 2015, 26, 2674-2681.	2.2	27
8	Degradation behaviors of micro ball grid array (µBGA) solder joints under the coupled effects of electromigration and thermal stress. Journal of Materials Science: Materials in Electronics, 2016, 27, 11583-11592.	2.2	17
9	Tunable MEMS cantilever resonators electrothermally actuated and piezoelectrically sensed. Microelectronic Engineering, 2015, 145, 38-42.	2.4	12
10	Optical lithography technique for the fabrication of devices from mechanically exfoliated two-dimensional materials. Microelectronic Engineering, 2016, 154, 62-68.	2.4	11
11	Mechanical Properties and Applications of Two-Dimensional Materials. , 0, , .		10
12	Electromigration failure of SnAgCu lead-free BGA package assembled with SnPb solder paste. , 2013, , .		1
13	Rapid formation of Cu-Sn intermetallic compounds by strong electric current. , 2014, , .		1
14	Effect of high temperature thermal aging on microstructural evolution of Sn ₃ Ag _{0.5} Cu/Cu solder joints. , 2013, , .		0
15	Growth mechanism of Cu-Sn full IMC joints on polycrystalline and single crystal Cu substrate. , 2013, , .		0